# **ACT108W-600E**

# **AC Thyristor power switch**

Rev. 03 — 21 October 2009

**Product data sheet** 

# 1. Product profile

## 1.1 General description

AC Thyristor power switch in a SOT223 surface-mountable plastic package with self-protective capabilities against low and high energy transients

### 1.2 Features and benefits

- Common terminal on mounting base allows multiple ACTs on shared cooling pad
- Exclusive negative gate triggering
- Full cycle AC conduction
- Remote gate separates the gate driver from the effects of the load current
- Safe clamping of low energy over-voltage transients
- Self-protective turn-on during high energy voltage transients
- Suface-mountable package
- Very high noise immunity

# 1.3 Applications

- Contactors, circuit breakers, valves, dispensers and door locks
- Fan motor circuits

- Lower-power highly inductive, resistive and safety loads
- Pump motor circuits

### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	-	600	V
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V; } I_T = 100 \text{ mA;}$ LD+ G-; $T_j = 25 \text{ °C;}$ see <u>Figure 10</u>	1	-	10	mA
		$V_D = 12 \text{ V}; I_T = 100 \text{ mA};$ LD- G-; $T_j = 25 \text{ °C}$	1	-	10	mA
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; T <sub>sp</sub> ≤ 112 °C; see <u>Figure 3</u> , <u>1</u> and <u>2</u>	-	-	0.8	Α
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 402 V; $T_j$ = 125 °C; gate open circuit; see Figure 14	1000	-	-	V/µs



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Table 1. Quick reference ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CL}$	clamping voltage	$I_{CL}$ = 100 mA; $t_p$ = 1 ms; $T_j \le$ 125 °C; see <u>Figure 17</u>	650	-	-	V
$V_{PP}$	peak pulse voltage	T <sub>j</sub> = 25 °C; non-repetitive, off-state; see <u>Figure 6</u>	-	-	2	kV
$V_{T}$	on-state voltage	I <sub>T</sub> = 1.1 A; see <u>Figure 13</u>	-	-	1.3	V

# **Pinning information**

Table 2. **Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	LD	load		
2	CM	common	4	LD 
3	G	gate		G <b>⊸o</b> ∏—
mb	СМ	mounting base; connected to common	□ 1 □ 2 □ 3 SOT223 (SC-73)	CM 001aaj924

#### **Ordering information** 3.

Table 3. **Ordering information** 

**Product data sheet** 

Type number	Package		
	Name	Description	Version
ACT108W-600E	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223

# 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	600	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; $T_{sp} \le 112$ °C; see Figure 3, 1 and 2	-	8.0	Α
I <sub>TSM</sub>	non-repetitive peak	full sine wave; $T_{j(init)} = 25$ °C; $t_p = 16.7$ ms	-	8.8	Α
on-state current	full sine wave; $T_{j(init)} = 25$ °C; $t_p = 20$ ms; see Figure 4 and 5	-	8	Α	
l <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms; sin-wave pulse	-	0.32	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_T = 1 \text{ A}$ ; $I_G = 20 \text{ mA}$ ; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$	-	100	A/µs
$I_{GM}$	peak gate current	t = 20 μs	-	1	Α
$V_{GM}$	peak gate voltage	positive applied gate voltage	-	15	V
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.1	W
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	125	°C
$V_{PP}$	peak pulse voltage	T <sub>j</sub> = 25 °C; non-repetitive, off-state; see Figure 6	-	2	kV

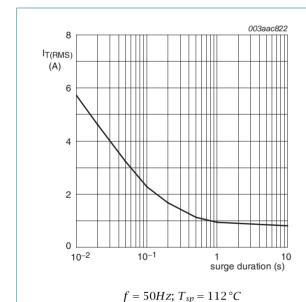


Fig 1. RMS on-state current as a function of surge duration; maximum values

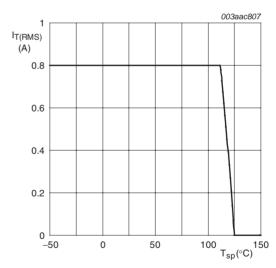


Fig 2. RMS on-state current as a function of solder point temperature; maximum values

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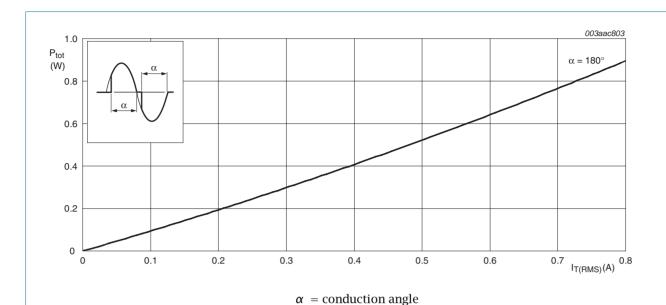


Fig 3. Total power dissipation as a function of RMS on-state current; maximum values

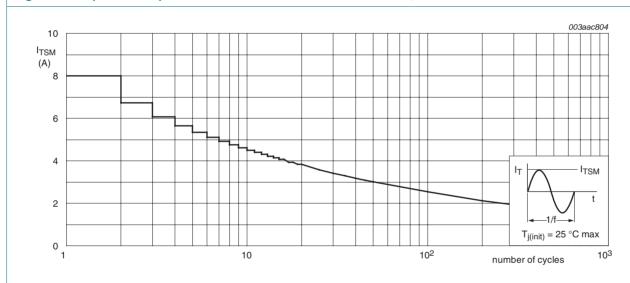


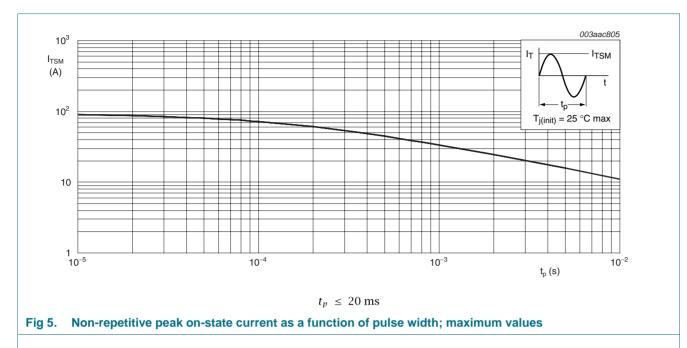
Fig 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

 $f = 50 \,\mathrm{Hz}$ 

**Product data sheet** 

**AC Thyristor power switch** 

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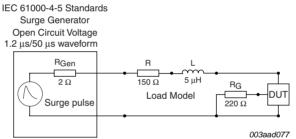
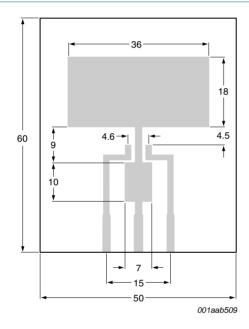


Fig 6. Test circuit for inductive and resistive loads with conditions equivalent to IEC 61000-4-5

# 5. Thermal characteristics

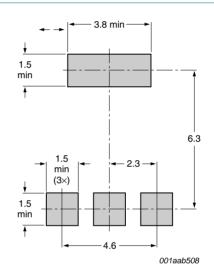
Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	full cycle with heatsink compound; see Figure 9	-	-	15	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	full cycle; printed-circuit board mounted for pad area; see Figure 7	-	70	-	K/W
		full cycle; printed-circuit board mounted for minimum footprint; see Figure 8	-	156	-	K/W



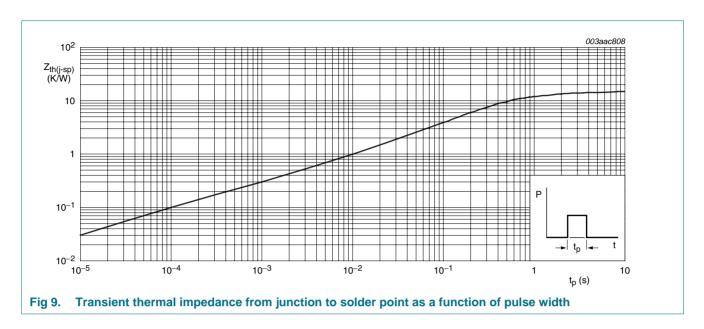
All dimensions are in mm Printed–circuit board: FR4 epoxy glass (1.6 mm thick), copper laminate (35 $\mu$ m thick)

Fig 7. Printed-circuit board pad area SOT223



All dimensions are in mm

Fig 8. Minimum footprint SOT223



#### **Characteristics** 6.

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$I_{GT}$	gate trigger current	$V_D = 12 \text{ V; } I_T = 100 \text{ mA; LD+ G-;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 10}}{Implies of the control $	1	-	10	mA
		$V_D = 12 \text{ V}; I_T = 100 \text{ mA}; LD- G-; T_j = 25 ^{\circ}\text{C}$	1	-	10	mΑ
lL	latching current	$V_D = 12 \text{ V}; I_G = 12 \text{ mA}; T_j = 25 ^{\circ}\text{C};$ see Figure 11	-	-	30	mA
I <sub>H</sub>	holding current	$V_D = 12 \text{ V; } T_j = 25 \text{ °C; see } \frac{\text{Figure } 12}{}$	-	9	25	mA
$V_{T}$	on-state voltage	I <sub>T</sub> = 1.1 A; see <u>Figure 13</u>	-	-	1.3	V
$V_{GT}$	gate trigger voltage	$V_D = 600 \text{ V}; I_T = 100 \text{ mA}; T_j \le 125 \text{ °C}$	0.15	-	-	V
		$V_D = 600 \text{ V}; I_T = 100 \text{ mA}; T_j = 25 \text{ °C}$	-	-	1	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 600 V; T <sub>j</sub> ≤ 125 °C	-	-	0.2	mΑ
		$V_D = 600 \text{ V}; T_j \le 25 \text{ °C}$	-	-	2	μΑ
dV <sub>D</sub> /dt	rate of rise of off-state voltage	V <sub>DM</sub> = 402 V; T <sub>j</sub> = 125 °C; gate open circuit; see <u>Figure 14</u>	1000	-	-	V/µs
dl <sub>com</sub> /dt	rate of change of commutating current	$V_D = 400 \text{ V; } T_j = 125 \text{ °C; } I_{T(RMS)} = 1 \text{ A;}$ dV <sub>com</sub> /dt = 15 V/µs; gate open circuit; see <u>Figure 15</u> and <u>16</u>	0.3	-	-	A/ms
V <sub>CL</sub>	clamping voltage	$I_{CL}$ = 100 mA; $t_p$ = 1 ms; $T_j \le$ 125 °C; see <u>Figure 17</u>	650	-	-	V

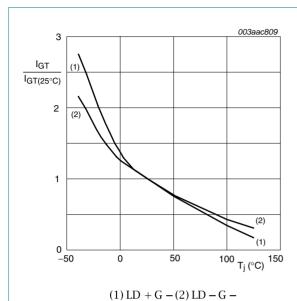


Fig 10. Normalized gate trigger current as a function of junction temperature

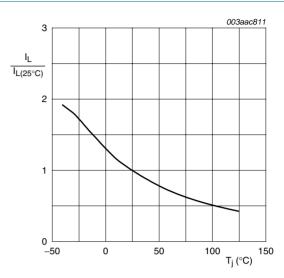


Fig 11. Normalized latching current as a function of junction temperature

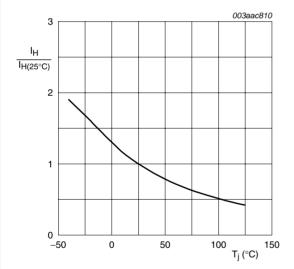
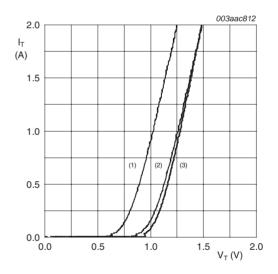


Fig 12. Normalized holding current as a function of junction temperature



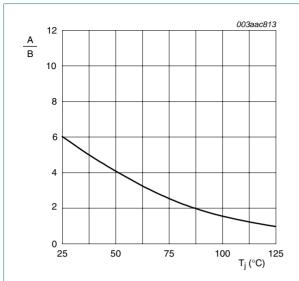
 $V_o = 1.043 \text{ V}; R_s = 0.239 \Omega$ 

(1)  $T_j = 125$  °C; typical values

(2)  $T_j = 125$  °C; maximum values

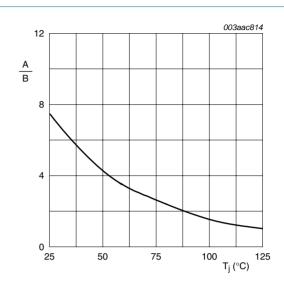
(3)  $T_j = 25$  °C; maximum values

Fig 13. On-state current as a function of on-state voltage



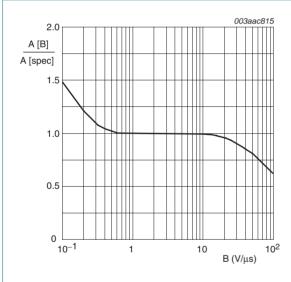
A is  $dV_D/dt$  at condition  $T_j$  °C B is  $dV_D/dt$  at condition  $T_i = 125$  °C

Fig 14. Normalized rate of rise of off-state voltage as a function of junction temperature



A is  $dI_{com}/dt$  at condition  $T_j$  °C B is  $dI_{com}/dt$  at  $T_j = 125$  °CV<sub>D</sub> = 400 V

Fig 15. Normalized critical rate of rise of commutating current as a function of junction temperature



A[B] is  $\frac{dI_{com}}{dt}$  at condition B,  $\frac{dV_{com}}{dt}$ A[spec] is the specified data sheet value of  $\frac{dI_{com}}{dt}$ 

Fig 16. Normalized critical rate of change of commutating current as a function of critical rate of change of commutating voltage; minimum values

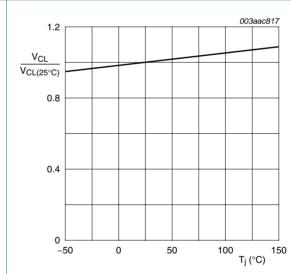


Fig 17. Normalized clamping voltage (upper limit) as a function of junction temperature; minimum values

# 7. Package outline

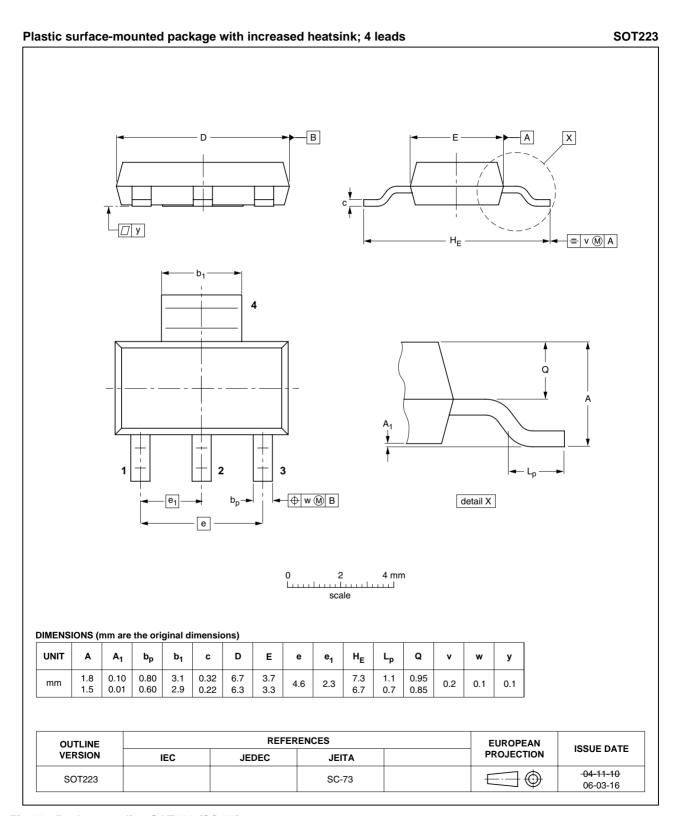


Fig 18. Package outline SOT223 (SC-73)

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# **Revision history**

#### Table 7. **Revision history**

**Product data sheet** 

Document ID	Release date	Data sheet status	Change notice	Supersedes
ACT108W-600E_3	20091021	Product data sheet	-	ACT108W-600E_2
Modifications:	<ul> <li>Various cha</li> </ul>	anges to content.		
ACT108W-600E_2	20090526	Product data sheet	-	ACT108W-600E_1
ACT108W-600E_1	20090429	Product data sheet	-	-

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### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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- [2] The term 'short data sheet' is explained in section "Definitions"
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